

<p>Substitute form 1449A/PTO</p> <p>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</p> <p>(use as many sheets as necessary)</p> <p>Sheet B1 of B1</p>				<p>Complete if Known</p> <table border="1"> <tr> <td>Application Number</td> <td>10/611,650</td> </tr> <tr> <td>Filing Date</td> <td>July 1, 2003</td> </tr> <tr> <td>First Named Inventor</td> <td>Adnan H. Anbuky</td> </tr> <tr> <td>Group Art Unit</td> <td>2838</td> </tr> <tr> <td>Examiner Name</td> <td>Michael Jude Sherry</td> </tr> <tr> <td>Attorney Docket Number</td> <td>9405-2</td> </tr> </table>		Application Number	10/611,650	Filing Date	July 1, 2003	First Named Inventor	Adnan H. Anbuky	Group Art Unit	2838	Examiner Name	Michael Jude Sherry	Attorney Docket Number	9405-2
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U.S. PATENTS AND PATENT PUBLICATIONS

FOREIGN PATENT DOCUMENTS

OTHER NON PATENT LITERATURE DOCUMENTS

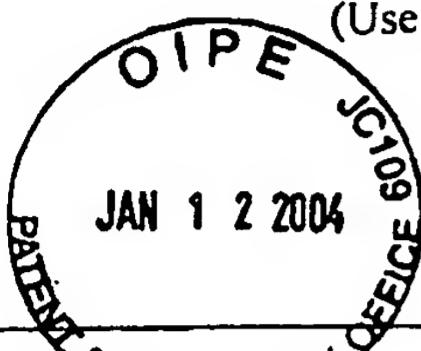
Examiner Signature

Dear [Name]

Date Considered

10-19-05

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FORM PTO-1449 U.S. Department of Commerce Patent and Trademark Office				Attorney Docket Number 9405-2		Serial No. 10/611,650	
LIST OF DOCUMENTS CITED BY APPLICANT <div style="text-align: center;">  (Use several sheets if necessary) </div>				Applicants: Anbuky et al. Filing Date: July 1, 2003 Group 1745			
U. S. PATENT DOCUMENTS							
Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date if Appropriate
<i>RL</i>	1.	6,255,801	7/3/01	Chalasani	320	132	
	2.	6,104,967	8/15/00	Hagen et al.	700	293	
	3.	6,064,180	5/16/00	Sullivan et al.	320	132	
	4.	5,825,156	10/20/98	Patillon et al.	320	21	
	5.	5,822,495	10/13/98	Wang et al.	395	3	
	6.	5,786,640	7/28/98	Sakai et al.	290	17	
	7.	5,773,962	6/30/98	Nor	320	134	
	8.	5,663,626	9/2/97	D'Angelo et al.	318	799	
	9.	5,619,417	4/8/97	Kendall	364	483	
	10.	5,587,924	12/24/96	Rossi	364	496	
	11.	5,587,660	12/24/96	Chabbert et al.	324	426	
	12.	5,371,682	12/6/94	Levine et al.	364	483	
	13.	5,130,659	7/14/92	Sloan	324	435	
<i>RL</i>	14.	4,952,862	8/28/90	Biagetti et al.	320	48	
<i>RL</i>	15.	4,876,513	10/24/89	Brilmyer et al.	324	427	
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Subclass	Translation Yes No
<i>RL</i>	16.	0 714 033	5/29/96	Europe			
<i>RL</i>	17.	2 734 061	11/15/96	France			
<i>RL</i>	18.	WO96/15563	5/23/96	PCT			
<i>RL</i>	19.	WO98/32181	7/23/98	PCT			
<i>RL</i>	20.	WO98/40951	9/17/98	PCT			
<i>RL</i>	21.	WO99/27628	6/3/99	PCT			
<i>RL</i>	22.	WO99/34224	7/8/99	PCT			
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)							

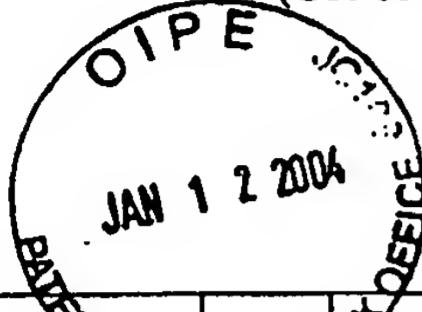
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LIST OF DOCUMENTS CITED BY APPLICANT (Use several sheets if necessary)			
 <p>Applicants: Anbuky et al.</p>			
		Filing Date: July 1, 2003	Group 1745
23.	IEEE Recommended Practice for Maintenance, Testing, and Replacement of Valve-Regulated Lead-Acid (VRLA) Batteries for Stationary Applications," IEEE Std 1188-1996, 16 pages		
24.	Alber et al., "Impedance Testing – Is it a Substitute for Capacity Testing," INTELEC 1994, 10-1, pp. 245-249		
25.	Anbuky et al., "Knowledge Based VRLA Battery Monitoring and Health Assessment," IEEE, 2000, pp. 687-694		
26.	Cun et al., "The Experience of a UPS Company in Advanced Battery Monitoring," INTELEC 1996, 22-5, pp. 646-653		
27.	International Search Report, PCT/NZ01/00183, July 23, 2002		
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29.	Konya et al., "A Deterioration Estimating System for 200-Ah Sealed Lead-Acid Batteries," 1994 IEEE, pp. 256-262		
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33.	Ng et al., "Evaluation of a Reverse Time Prediction Algorithm for Lead Acid Battery," INTELEC 1996, pp. 616-623		
34.	Pascoe et al., "Estimation of VRLA Battery Capacity Using The Analysis of The Coup De Fouet Region," 1999 IEEE, 9 pages		
35.	Pascoe et al., "VRLA Battery Capacity Measurement and Discharge Reserve Time Prediction," 1998 IEEE, pp. 302-310		
36.	Suntio et al., "The Batteries as a Principal Component in DC UPS Systems," IEEE, 1990, pp. 400-411		
37.	Supplementary European Search Report, EP 99 94 0753, June 25, 2002		
38.	Troy et al., "Midpoint Conductance Technology Used in Telecommunication Stationary Standby Battery Applications, Part VI, Considerations for Deployment of Midpoint Conductance in Telecommunications Power Applications," INTELEC 1997, 29-4, pp. 695-702		
39.	Yamamoto et al., "Deterioration Estimation Method for 200-Ah Sealed Lead-Acid Batteries," NTT Review, Vol. 7, No. 4, July 1995, pp. 65-69		
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